

Notice of References Cited	Application/Control No. 10/631,058	Applicant(s)/Patent Under Reexamination DAY ET AL.	
	Examiner Brian P. Whipple	Art Unit 2152	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0044144 A1	02-2005	Malik et al.	709/205
*	B	US-2003/0046421 A1	03-2003	Horvitz et al.	709/238
*	C	US-6,157,630	12-2000	Adler et al.	370/338
*	D	US-6,208,859 B1	03-2001	Halvorson, David H.	455/430
*	E	US-2002/0058522 A1	05-2002	Kim et al.	455/466
*	F	US-2002/0112014 A1	08-2002	Bennett et al.	709/206
*	G	US-6,697,844 B1	02-2004	Chan et al.	709/206
*	H	US-2004/0266462 A1	12-2004	Chava et al.	455/466
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	QuikTxT, FAQs/How-To, 10/06/2002, Cellcom
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.